

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10574595	DOI ET AL.
	Examiner	Art Unit
	MARCOS BATISTA	4134

SEARCHED

Class	Subclass	Date	Examiner
370	376	6/4/2008	mb
370	509	6/4/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted w/ lab TA Yogesh Aggarwal	6/9/2008	mb
Consulted with Lun-Yi Lao	6/9/2008	mb
East Search	6/9/2008	mb
Inventor's Name Search	6/9/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner